

Normally – OFF Silicon Carbide Junction Transistor

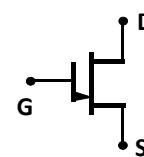
| | | |
|---------------------------|---|---------------|
| V_{DS} | = | 650 V |
| V_{DS(ON)} | = | 1.7 V |
| I_D | = | 4 A |
| R_{DS(ON)} | = | 415 mΩ |

Features

- 250 °C maximum operating temperature
- Temperature independent switching performance
- Electrically isolated base-plate
- Gate oxide free SiC switch
- Suitable for connecting an anti-parallel diode
- Positive temperature coefficient for easy paralleling
- Low gate charge
- Low intrinsic capacitance

Package

- RoHS Compliant



TO – 257 (Isolated Base-plate Hermetic Package)

Advantages

- Low switching losses
- Higher efficiency
- High temperature operation
- High short circuit withstand capability

Applications

- Down Hole Oil Drilling, Geothermal Instrumentation
- Hybrid Electric Vehicles (HEV)
- Solar Inverters
- Switched-Mode Power Supply (SMPS)
- Power Factor Correction (PFC)
- Induction Heating
- Uninterruptible Power Supply (UPS)
- Motor Drives

Maximum Ratings at T_j = 250 °C, unless otherwise specified

| Parameter | Symbol | Conditions | Values | Unit |
|-----------------------------------|-----------------------------------|-------------------------|------------|------|
| Drain – Source Voltage | V _{DS} | V _{GS} = 0 V | 650 | V |
| Continuous Drain Current | I _D | T _C = 165 °C | 4 | A |
| Gate Peak Current | I _{GM} | | 5 | A |
| Reverse Gate – Source Voltage | V _{GS} | | 30 | V |
| Reverse Drain – Source Voltage | V _{DS} | | 40 | V |
| Power Dissipation | P _{tot} | T _C = 25 °C | 7 | W |
| Operating and Storage Temperature | T _j , T _{stg} | | -55 to 250 | °C |

Electrical Characteristics at T_j = 250 °C, unless otherwise specified

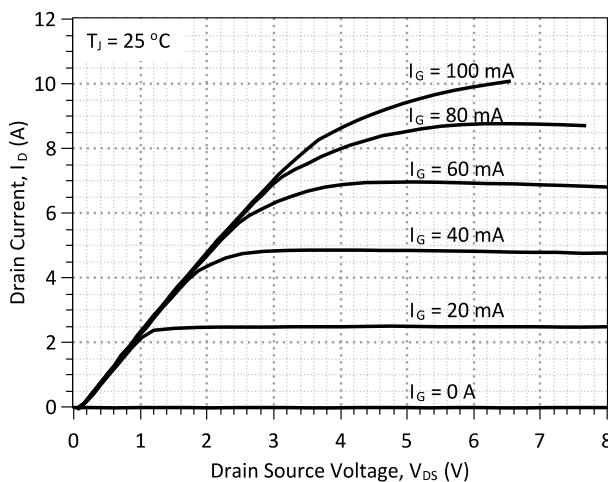
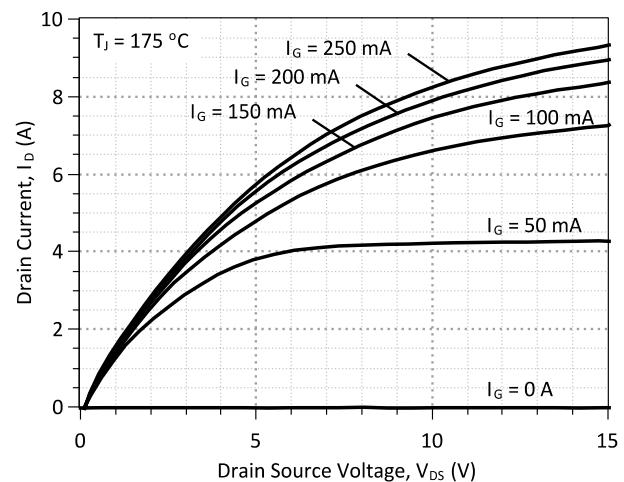
| Parameter | Symbol | Conditions | Values | | |
|------------------------------|----------------------|---|--------------------|------|------|
| | | | min. | typ. | max. |
| On Characteristics | | | | | |
| Drain – Source On Voltage | V _{DS(ON)} | I _D = 4 A, I _G = 100 mA, T _j = 25 °C I _D = 4 A, I _G = 250 mA, T _j = 175 °C I _D = 4 A, I _G = 250 mA, T _j = 250 °C | 1.7 3.2 4.7 | | V |
| Drain – Source On Resistance | R _{DS(ON)} | I _D = 4 A, I _G = 100 mA, T _j = 25 °C I _D = 4 A, I _G = 250 mA, T _j = 175 °C I _D = 4 A, I _G = 250 mA, T _j = 250 °C | 415 820 1310 | | mΩ |
| Gate Forward Voltage | V _{GS(FWD)} | I _G = 500 mA, T _j = 25 °C I _G = 500 mA, T _j = 250 °C | 3.3 3.2 | | V |
| DC Current Gain | β | V _{DS} = 5 V, I _D = 5 A, T _j = 25 °C V _{DS} = 5 V, I _D = 5 A, T _j = 250 °C | 120 85 | | |
| Off Characteristics | | | | | |
| Drain Leakage Current | I _{DSS} | V _R = 650 V, V _{GS} = 0 V, T _j = 25 °C V _R = 650 V, V _{GS} = 0 V, T _j = 175 °C V _R = 650 V, V _{GS} = 0 V, T _j = 250 °C | 7 25 105 | | nA |

Electrical Characteristics at $T_J = 250^\circ\text{C}$, unless otherwise specified

| Parameter | Symbol | Conditions | Values | | |
|----------------------------------|--------------|---|--------|------|---------------|
| | | | min. | typ. | max. |
| Dynamic Characteristics | | | | | |
| Input Capacitance | C_{iss} | $V_{DS} = 35 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}, T_J = 25^\circ\text{C}$ | 324 | | pF |
| Output Capacitance | C_{oss} | | 45 | | pF |
| Reverse Transfer Capacitance | C_{rss} | | 45 | | pF |
| Switching Characteristics | | | | | |
| Turn On Delay Time | $t_{d(on)}$ | $V_{DD} = 400 \text{ V}, I_D = 5 \text{ A}, R_{G(on)} = R_{G(off)} = 44 \Omega, V_{GS} = -8/15 \text{ V}, T_J = 175^\circ\text{C}$ Refer to Figure 10 for gate drive current waveforms | 5 | | ns |
| Rise Time | t_r | | 15 | | ns |
| Turn Off Delay Time | $t_{d(off)}$ | | 74 | | ns |
| Fall Time | t_f | | 14 | | ns |
| Turn-On Energy Per Pulse | E_{on} | | 24 | | μJ |
| Turn-Off Energy Per Pulse | E_{off} | | 7 | | μJ |
| Total Switching Energy | E_{ts} | | 31 | | μJ |
| Turn On Delay Time | $t_{d(on)}$ | | 9 | | ns |
| Rise Time | t_r | $V_{DD} = 400 \text{ V}, I_D = 5 \text{ A}, R_{G(on)} = R_{G(off)} = 44 \Omega, V_{GS} = -8/15 \text{ V}, T_J = 250^\circ\text{C}$ Refer to Figure 10 for gate drive current waveforms | 24 | | ns |
| Turn Off Delay Time | $t_{d(off)}$ | | 114 | | ns |
| Fall Time | t_f | | 17 | | ns |
| Turn-On Energy Per Pulse | E_{on} | | 54 | | μJ |
| Turn-Off Energy Per Pulse | E_{off} | | 10 | | μJ |
| Total Switching Energy | E_{ts} | | 64 | | μJ |

Thermal Characteristics

| | | | |
|-------------------------------------|------------|-----|--------------------|
| Thermal resistance, junction - case | R_{thJC} | 4.2 | $^\circ\text{C/W}$ |
|-------------------------------------|------------|-----|--------------------|


Figure 1: Typical Output Characteristics at 25°C

Figure 2: Typical Output Characteristics at 175°C

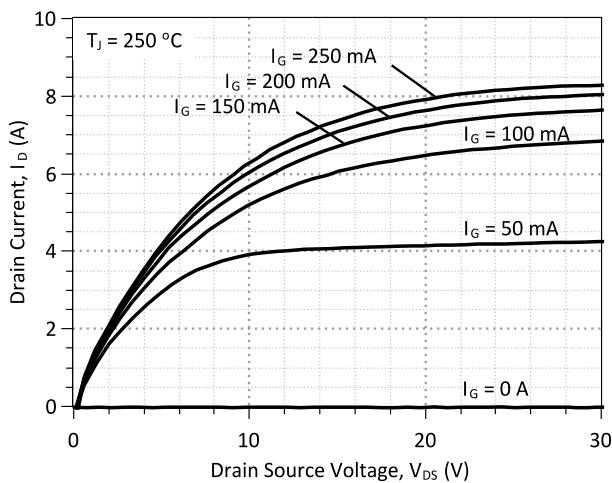


Figure 3: Typical Output Characteristics at 250 °C

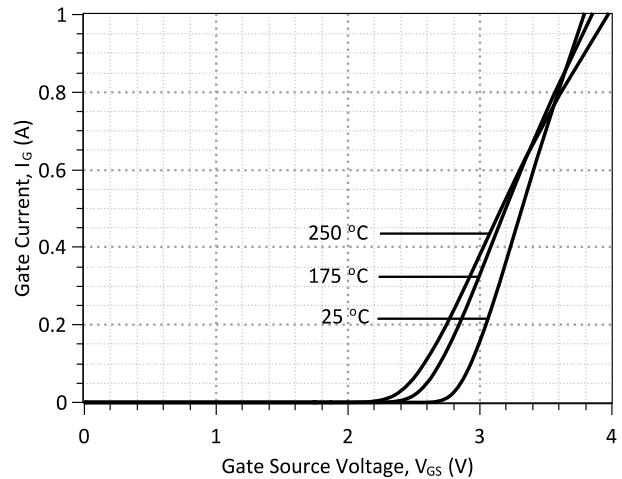


Figure 4: Typical Gate Source I-V Characteristics vs. Temperature

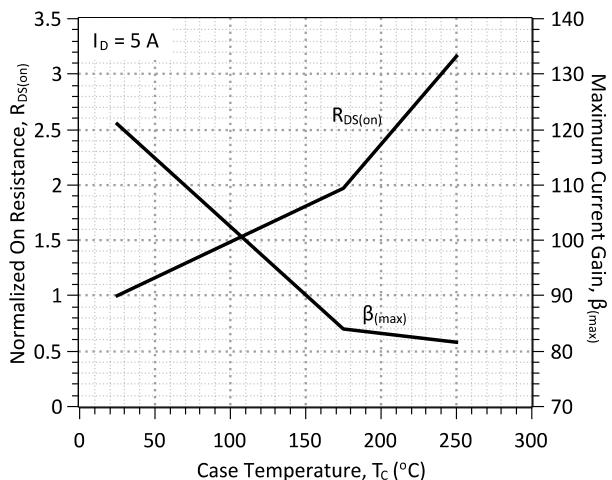


Figure 5: Normalized On-Resistance and Current Gain vs. Temperature

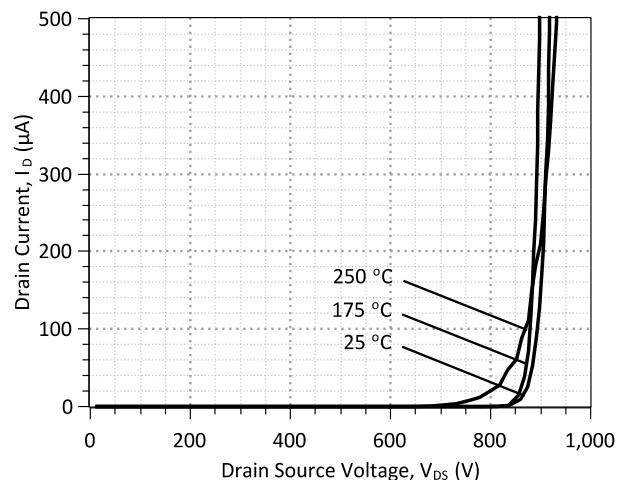


Figure 6: Typical Blocking Characteristics

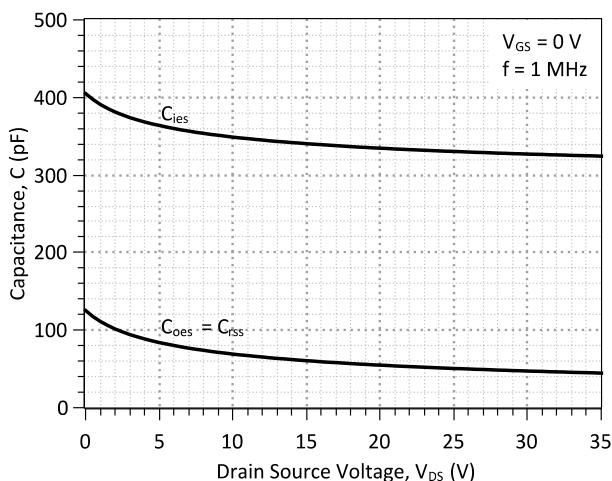


Figure 7: Typical Capacitance vs Drain-Source Voltage

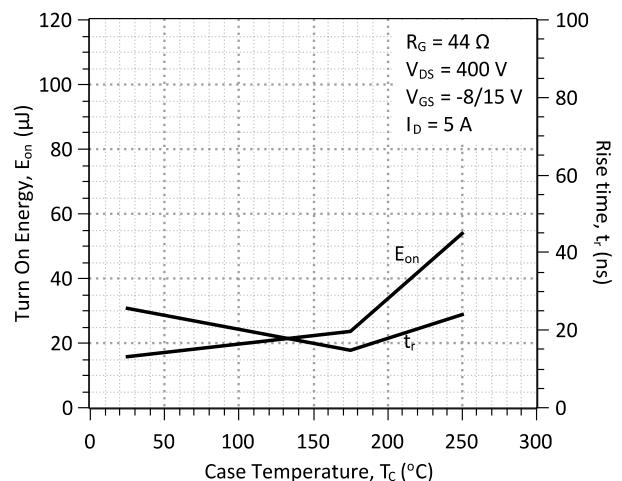
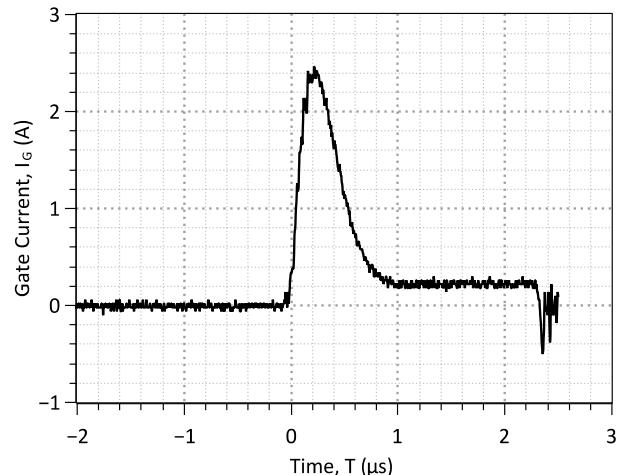
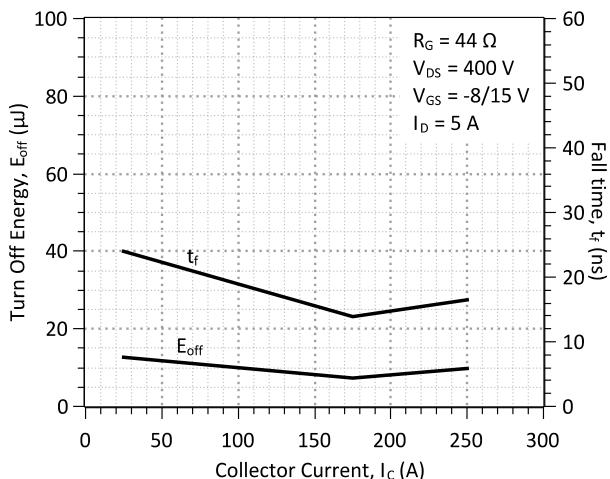
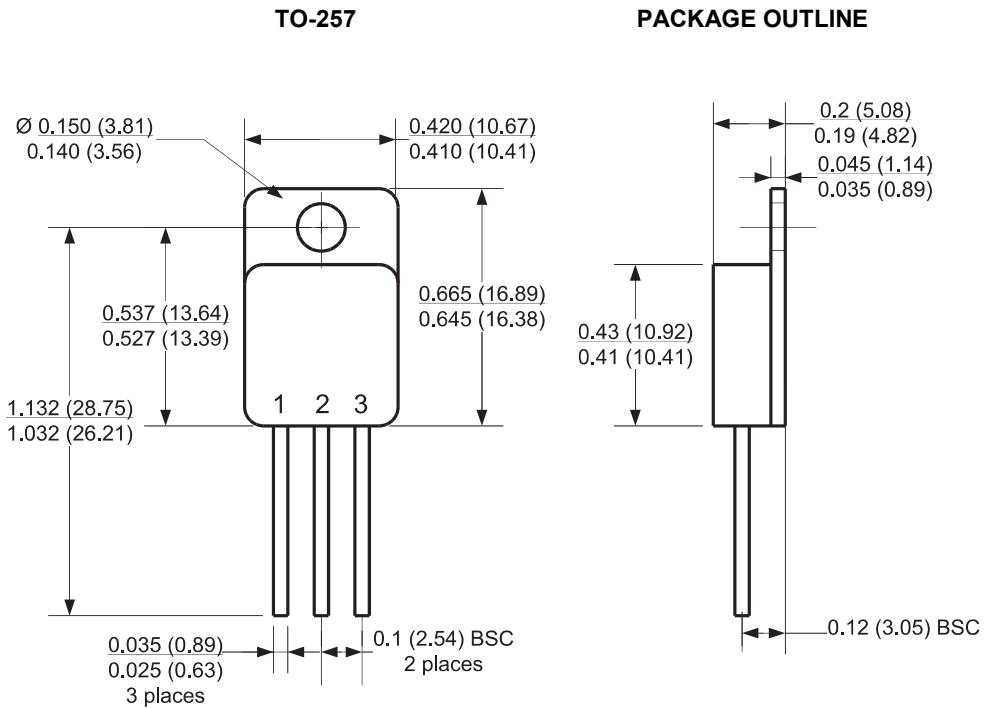


Figure 8: Typical Turn On Energy Losses and Switching Times vs. Temperature



Package Dimensions:



NOTE

1. CONTROLLED DIMENSION IS INCH. DIMENSION IN BRACKET IS MILLIMETER.
2. DIMENSIONS DO NOT INCLUDE END FLASH, MOLD FLASH, MATERIAL PROTRUSIONS

| Revision History | | | |
|-------------------------|----------|-----------------|------------|
| Date | Revision | Comments | Supersedes |
| 2012/08/24 | 0 | Initial release | |
| | | | |

Published by

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SPICE Model Parameters

Copy the following code into a SPICE software program for simulation of the 2N7635-GA device.

```
* MODEL OF GeneSiC Semiconductor Inc.  
*  
* $Revision: 1.0      $  
* $Date: 06-SEP-2013 $  
*  
* GeneSiC Semiconductor Inc.  
* 43670 Trade Center Place Ste. 155  
* Dulles, VA 20166  
* http://www.genesicsemi.com/index.php/sic-products/sjt  
*  
* COPYRIGHT (C) 2013 GeneSiC Semiconductor Inc.  
* ALL RIGHTS RESERVED  
*  
* These models are provided "AS IS, WHERE IS, AND WITH NO WARRANTY  
* OF ANY KIND EITHER EXPRESSED OR IMPLIED, INCLUDING BUT NOT LIMITED  
* TO ANY IMPLIED WARRANTIES OF MERCHANTABILITY AND FITNESS FOR A  
* PARTICULAR PURPOSE."  
* Models accurate up to 2 times rated drain current.  
*  
.model 2N7635 NPN  
+ IS      1.22E-47  
+ ISE     3.91E-27  
+ EG      3.23  
+ BF      110  
+ BR      0.55  
+ IKF     999  
+ NF      1  
+ NE      2.022  
+ RB      0.26  
+ RE      0.231  
+ RC      0.16  
+ CJC     1.37E-10  
+ VJC     3.173990516  
+ MJC     0.436428533  
+ CJE     3.36E-10  
+ VJE     2.944816511  
+ MJE     0.493905327  
+ XTI     3  
+ XTB     -0.45  
+ TRC1    1.50E-02  
+ VCEO    800  
+ ICRATING 4  
+ MFG     GeneSiC_Semiconductor  
*  
* End of 2N7635-GA SPICE Model
```